

SAW Components Data Sheet

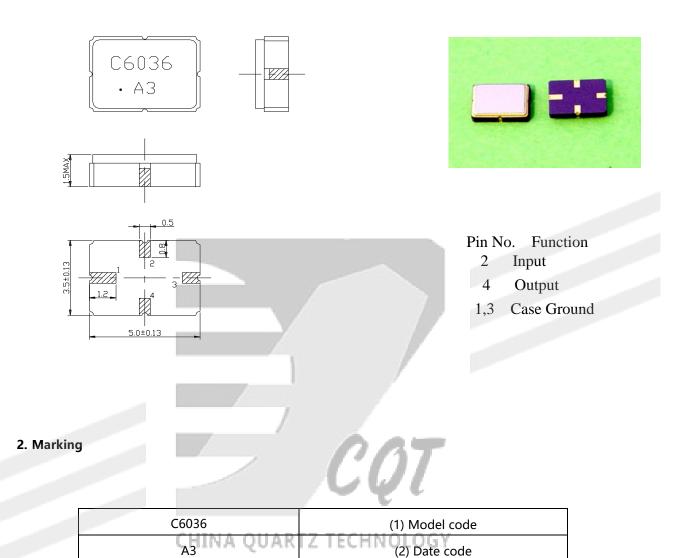
CQTSR407M30.00

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1. Package Dimension

Unit: mm



А	3
Month code	Last figure of year

Month	1	2	3	4	5	6	7	8	9	10	11	12
Month code	А	В	С	D	Е	F	G	Н	Ι	J	К	L

3. Performance

3.1 Application

One-port SAW Resonator for Wireless Remote Controller.

Center frequency: 407.3MHz

3.2 Maximum Rating

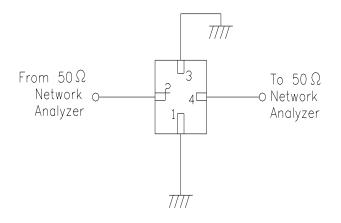
Rating		Value	Unit	
Operating Temperature Range	TA	-40 ~ +85	°C	
Storage Temperature Range	T stg	-45 ~ +125	°C	
DC Voltage (between any Terminals)	V _{DC}	10	V	
RF Power (in <i>BW</i>)	Р	10	dBm	
ESD Voltage (HB)	V _{ESD}	150	V	

Electrostatic Sensitive Device (ESD)

3.3 Electronic Characteristics

Item	Unit	Minimum	Typical	Maximum
Center Frequency (fo)	MHz	407.225	407.30	407.375
Insertion Loss	dB	- 1	1.3	2.0
Quality Factor	- /	_	_	_
Unloaded Q	-	_	14,000	_
50Ω Loaded Q	00		1,500	—
Temperature Stability		/	_	
Turnover Temperature	ĉ		39	
Frequency Temperature Coefficient	ppm/°C ²	_	0.032	_
Frequency Aging CHINA QUARIZ	ppm/yr	LOGY	<±10	
DC Insulation Resistance	MΩ	1.0	_	
RF Equivalent RLC Model	_			
Motional Resistance R ₁	Ω		12	22
Motional Inductance L ₁	μH		66	
Motional Capacitance C ₁	fF	_	2.3	_
Shunt Static Capacitance C ₀	pF	1.4	1.7	2.0

3.4 Test Circuit



4 Reliability

- 4.1 Mechanical Shock: The components shall remain within the electrical specifications after three one-half sine shock pulses(3000g's for 0.3 ms) in each direction(for six total) along each of the three mutually perpendicular axes for a total of 18 shocks.
- 4.2 Vibration Fatigue: The components shall remain within the electrical specifications after loaded vibration at 20~55Hz, amplitude 1.5mm, X,Y,Z, direction, for 2 hours.
- 4.3 Leak Test
- 4.3.1 Gross Leak Test: Submerge samples into at +85°C water for at least 1 minute. Carefully observe the samples. No bubbles should be seen.
- 4.3.2 Fine Leak Test: Expose samples for testing to 60 PSIG Helium gas for 2 hours. Then transfer the same samples to another chamber and draw a vacuum. Measure the leak rate. Failure is defined if the leak rate exceeds 5×10⁻⁸ atm cc/sec Helium.
- 4.4 High Temperature Storage: The components shall remain within the electrical specifications after being kept at the 85°C±2°Cfor 960 hours, then kept at room temperature for 2 hours.
- 4.5 Low Temperature Storage: The components shall remain within the electrical specifications after being kept at the 40°C±2°Cfor 960 hours, then kept at room temperature for 2 hours.
- 4.6 Temperature Cycle: The components shall remain within the electrical specification after 32 cycles of high and low temperature testing (one cycle: 80°C for 30 minutes → 25°C for 20 seconds → -40°C for 30 minutes) than kept at room temperature for 2 hours.
- 4.7 Humidity Test: The components shall remain within the electrical specifications after being kept at the condition of ambient temperature 70°C, and 90~95% RH for 240 hours, then kept at room temperature and normal humidity for 4 hours.
- 4.8 Solder-heat Resistance: The components shall remain within the electrical specifications after dipped in the solder at 260°C±5°C for 10 to 11 seconds, then kept at room temperature for 10 minutes.
- 4.9 Solderability: Solderability of terminal shall be kept at more than 80% after dipped in the solder flux at 230℃±5℃ for 5±1 seconds.
- 4.10 Storage: The components shall meet the electrical and mechanical specifications after 5 years storage, if stored within the temperature range of $-40^{\circ}C \sim +85^{\circ}C$ and in the humidity of 20 to 60% r.h.